

Search Notes 				Application/Control No. 10/658,275 Examiner Dah-Wei D. Yuan	Applicant(s)/Patent under Reexamination HICKEY ET AL. Art Unit 1745	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
Class	Subclass	Date	Examiner		DATE	EXMR
429	12	3/8/2006	DWY	EAST	3/8/2006	DWY
429	30	3/8/2006	DWY	STN	3/8/2006	DWY
429	46	3/8/2006	DWY			
INTERFERENCE SEARCHED				 		
Class	Subclass	Date	Examiner			
 				 		